

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/676,892	MERFELD ET AL.	
Examiner		Art Unit		Page 1 of 3
Vivian Chen		1773		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0016626	08-2001	Vollenberg et al.	525/165
*	B	US-2005/0159543	07-2005	Acar et al.	525/048
*	C	US-2005/0159542	07-2005	Acar et al.	525/040
*	D	US-5,037,903	08-1991	Parker, Theodore L.	525/438
*	E	US-2003/0207123	11-2003	Brunelle et al.	428/423.7
*	F	US-5,387,639	02-1995	Sybert et al.	524/537
*	G	US-4,786,708	11-1988	Serini et al.	528/176
*	H	US-5,916,997	06-1999	Webb et al.	528/194
*	I	US-4,556,606	12-1985	Olson, Daniel R.	428/412
*	J	US-6,143,839	11-2000	Webb et al.	525/439
*	K	US-6,306,507	10-2001	Brunelle et al.	428/423.7
*	L	US-6,265,522	07-2001	Brunelle et al.	528/194
*	M	US-6,294,647	09-2001	Brunelle et al.	528/486

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/676,892	MERFELD ET AL.	
			Examiner	Art Unit	
			Vivian Chen	1773	Page 2 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,291,589	09-2001	Brunelle et al.	525/165
*	B	US-5,777,009	07-1998	Pan et al.	524/164
*	C	US-6,610,409	08-2003	Pickett et al.	428/423.7
*	D	US-6,538,065	03-2003	Suriano et al.	525/182
*	E	US-6,228,910	05-2001	Shakhnovich, Alexander Isaakovich	524/88
*	F	US-6,583,256	06-2003	Vollenberg et al.	528/196
*	G	US-2005/0288406	12-2005	Gallucci et al.	524/115
*	H	US-2006/0004152	01-2006	Acar et al.	525/439
*	I	US-2005/0159577	07-2005	Davis et al.	528/198
*	J	US-2005/0049369	03-2005	O'Neil et al.	525/439
*	K	US-2003/0216539	11-2003	Siclovan et al.	528/272
*	L	US-2003/0195325	10-2003	Silva et al.	528/196
*	M	US-3,460,961	08-1969	MARKHART ALBERT H; et. al.	428/216

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination MERFELD ET AL.	
		Examiner Vivian Chen	Art Unit 1773	Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0180542	09-2003	Pickett et al.	428/423.7
*	B	US-2003/0175488	09-2003	Asthana et al.	428/212
*	C	US-2002/0039657	04-2002	Brunelle et al.	428/423.7
*	D	US-6,861,482	03-2005	Brunelle et al.	525/439
*	E	US-6,812,320	11-2004	Silva et al.	528/198
*	F	US-6,689,474	02-2004	Pickett et al.	428/423.7
*	G	US-6,627,303	09-2003	Gallucci et al.	428/212
*	H	US-6,596,843	07-2003	Brunelle et al.	528/486
*	I	US-6,559,270	05-2003	Siclovan et al.	528/196
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.